

## 50mA and 100mA CMOS LDOs with Shutdown, ERROR Output, and $V_{REF}$ Bypass

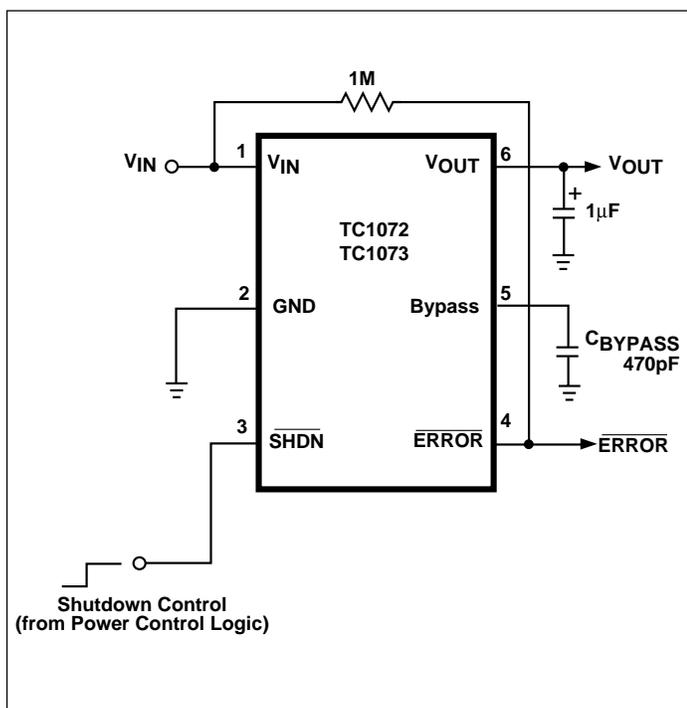
### FEATURES

- Zero Ground Current for Longer Battery Life!
- Very Low Dropout Voltage
- Choice of 50mA and 100mA Output (TC1072, TC1073, Respectively)
- High Output Voltage Accuracy
- Standard or Custom Output Voltages
- Power-Saving Shutdown Mode
- ERROR Output can be Used as a Low Battery Detector, or Processor Reset Generator
- Bypass Input for Ultra-Quiet Operation
- Over-Current and Over-Temperature Protection
- Space-Saving 6-Pin SOT-23A Package
- Pin Compatible Upgrades for Bipolar Regulators

### APPLICATIONS

- Battery Operated Systems
- Portable Computers
- Medical Instruments
- Instrumentation
- Cellular / GSM / PHS Phones
- Linear Post-Regulator for SMPS
- Pagers

### TYPICAL APPLICATION



### GENERAL DESCRIPTION

The TC1072 and TC1073 are high accuracy (typically  $\pm 0.5\%$ ) CMOS upgrade for older (bipolar) low dropout regulators. Designed specifically for battery-operated systems, the devices' CMOS construction eliminates wasted ground current, significantly extending battery life. Total supply current is typically  $50\mu\text{A}$  at full load, 20 to 60 times lower than in bipolar regulators!

The devices' key features include ultra low noise operation (plus optional Bypass input); very low dropout voltage (typically  $85\text{mV}$ , TC1072 and  $180\text{mV}$ , TC1073 at full load) and fast response to step changes in load. An error output (ERROR) is asserted when the devices are out-of-regulation (due to a low input voltage or excessive output current). ERROR can be used as a low battery warning or as a processor RESET signal (with the addition of an external RC network). Supply current is reduced to  $0.5\mu\text{A}$  (max), and both  $V_{\text{OUT}}$  and ERROR are disabled when the shutdown input is low. The devices incorporate both over-temperature and over-current protection.

The TC1072 and TC1073 are stable with an output capacitor of only  $1\mu\text{F}$  and have a maximum output current of 50mA. For higher output current versions, please see the TC1185, TC1186, TC1187 ( $I_{\text{OUT}} = 150\text{mA}$ ) and TC1107, TC1108, and TC1173 ( $I_{\text{OUT}} = 300\text{mA}$ ) data sheets.

### ORDERING INFORMATION

Part Number	Package	Junction Temp. Range
TC1072-xxVCH	6-Pin SOT-23A*	$-40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$
TC1073-xxVCH	6-Pin SOT-23A*	$-40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$

### TC1015EV Evaluation Kit for CMOS LDO Family

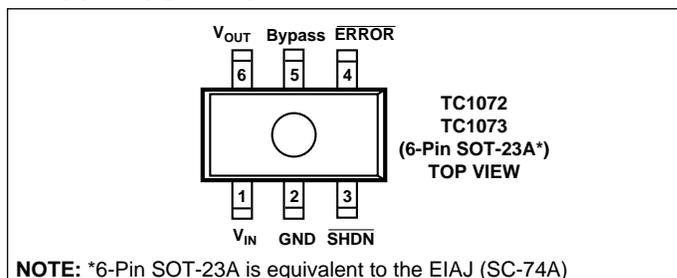
NOTE: \*6-Pin SOT-23A is equivalent to the EIAJ (SC-74A).

#### Available Output Voltages:

2.5, 2.7, 2.8, 2.85, 3.0, 3.3, 3.6, 4.0, 5.0  
xx indicates output voltages

Other output voltages are available. Please contact Microchip Technology for details.

### PIN CONFIGURATION



NOTE: \*6-Pin SOT-23A is equivalent to the EIAJ (SC-74A)

# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

## TC1072 TC1073

### ABSOLUTE MAXIMUM RATINGS\*

Input Voltage .....	6.5V
Output Voltage .....	(- 0.3) to (V <sub>IN</sub> + 0.3)
Power Dissipation .....	Internally Limited
Operating Temperature .....	- 40°C < T <sub>J</sub> < 125°C
Storage Temperature .....	- 65°C to +150°C
Maximum Voltage on Any Pin .....	V <sub>IN</sub> + 0.3V to - 0.3V
Lead Temperature (Soldering, 10 Sec.) .....	+260°C

\*Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**ELECTRICAL CHARACTERISTICS:** V<sub>IN</sub> = V<sub>OUT</sub> + 1V, I<sub>L</sub> = 0.1mA, C<sub>L</sub> = 3.3μF,  $\overline{\text{SHDN}} > V_{IH}$ , T<sub>A</sub> = 25°C, unless otherwise specified. **BOLDFACE** type specifications apply for junction temperatures of - 40°C to +125°C.

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
V <sub>IN</sub>	Input Operating Voltage		—	—	<b>6.0</b>	V
I <sub>OUTMAX</sub>	Maximum Output Current	TC1072 TC1073	<b>50</b> <b>100</b>	— —	— —	mA mA
V <sub>OUT</sub>	Output Voltage	Note 1	<b>V<sub>R</sub> - 2.5%</b>	V <sub>R</sub> ±0.5%	<b>V<sub>R</sub> + 2.5%</b>	V
TC V <sub>OUT</sub>	V <sub>OUT</sub> Temperature Coefficient	Note 2	— —	20 <b>40</b>	— —	ppm/°C
ΔV <sub>OUT</sub> /ΔV <sub>IN</sub>	Line Regulation	(V <sub>R</sub> + 1V) ≤ V <sub>IN</sub> ≤ 6V	—	0.05	<b>0.35</b>	%
ΔV <sub>OUT</sub> /V <sub>OUT</sub>	Load Regulation	I <sub>L</sub> = 0.1mA to I <sub>OUTMAX</sub> (Note 3)	—	0.5	<b>2.0</b>	%
V <sub>IN</sub> - V <sub>OUT</sub>	Dropout Voltage (Note 4)	I <sub>L</sub> = 0.1mA I <sub>L</sub> = 20mA I <sub>L</sub> = 50mA I <sub>L</sub> = 100mA (TC1073) (Note 4)	— — — —	2 65 85 180	— — <b>120</b> <b>250</b>	mV
I <sub>IN</sub>	Supply Current (Note 8)	$\overline{\text{SHDN}} = V_{IH}$ , I <sub>L</sub> = 0	—	50	<b>80</b>	μA
I <sub>INSD</sub>	Shutdown Supply Current	$\overline{\text{SHDN}} = 0V$	—	0.05	<b>0.5</b>	μA
PSRR	Power Supply Rejection Ratio	F <sub>RE</sub> ≤ 1 KHz	—	64	—	dB
I <sub>OUTSC</sub>	Output Short Circuit Current	V <sub>OUT</sub> = 0V	—	300	450	mA
ΔV <sub>OUT</sub> /ΔP <sub>D</sub>	Thermal Regulation	Notes 5, 6	—	0.04	—	V/W
T <sub>SD</sub>	Thermal Shutdown Die Temperature		—	160	—	°C
ΔT <sub>SD</sub>	Thermal Shutdown Hysteresis		—	10	—	°C
eN	Output Noise	I <sub>L</sub> = I <sub>OUTMAX</sub> 470pF from Bypass to GND	—	260	—	nV/√Hz

### SHDN Input

V <sub>IH</sub>	SHDN Input High Threshold	V <sub>IN</sub> = 2.5V to 6.5V	45	—	—	%V <sub>IN</sub>
V <sub>IL</sub>	SHDN Input Low Threshold	V <sub>IN</sub> = 2.5V to 6.5V	—	—	15	%V <sub>IN</sub>

# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

TC1072  
TC1073

**ELECTRICAL CHARACTERISTICS:** V<sub>IN</sub> = V<sub>OUT</sub> + 1V, I<sub>L</sub> = 0.1mA, C<sub>L</sub> = 3.3μF,  $\overline{\text{SHDN}} > V_{IH}$ , T<sub>A</sub> = 25°C, unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>ERROR Open Drain Output</b>						
V <sub>INMIN</sub>	Minimum V <sub>IN</sub> Operating Voltage		1.0	—	—	V
V <sub>OL</sub>	Output Logic Low Voltage	1mA Flows to $\overline{\text{ERROR}}$	—	—	400	mV
V <sub>TH</sub>	$\overline{\text{ERROR}}$ Threshold Voltage	See Figure 2	—	0.95 x V <sub>R</sub>	—	V
V <sub>HYS</sub>	$\overline{\text{ERROR}}$ Positive Hysteresis	Note 7	—	50	—	mV

- NOTES:**
- V<sub>R</sub> is the regulator output voltage setting. V<sub>R</sub> = 2.5V, 2.7V, 2.85V, 3.0V, 3.3V, 3.6V, 4.0V, 5.0V.
  - TC V<sub>OUT</sub> =  $\frac{(V_{OUTMAX} - V_{OUTMIN}) \times 10^6}{V_{OUT} \times \Delta T}$
  - Regulation is measured at a constant junction temperature using low duty cycle pulse testing. Load regulation is tested over a load range from 0.1mA to the maximum specified output current. Changes in output voltage due to heating effects are covered by the thermal regulation specification.
  - Dropout voltage is defined as the input to output differential at which the output voltage drops 2% below its nominal value.
  - Thermal Regulation is defined as the change in output voltage at a time T after a change in power dissipation is applied, excluding load or line regulation effects. Specifications are for a current pulse equal to I<sub>LMAX</sub> at V<sub>IN</sub> = 6V for T = 10 msec.
  - The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction-to-air (i.e. T<sub>A</sub>, T<sub>J</sub>, θ<sub>JA</sub>). Exceeding the maximum allowable power dissipation causes the device to initiate thermal shutdown. Please see Thermal Considerations section of this data sheet for more details.
  - Hysteresis voltage is referenced by V<sub>R</sub>.
  - Apply for Junction Temperatures of -40°C to +85°C.

## PIN DESCRIPTION

Pin No.	Symbol	Description
(6-Pin SOT-23A) 1	V <sub>IN</sub>	Unregulated supply input.
2	GND	Ground terminal.
3	$\overline{\text{SHDN}}$	Shutdown control input. The regulator is fully enabled when a logic high is applied to this input. The regulator enters shutdown when a logic low is applied to this input. During shutdown, output voltage falls to zero and supply current is reduced to 0.05 μA (typical).
4	$\overline{\text{ERROR}}$	Out-of-Regulation Flag. (Open drain output). This output goes low when V <sub>OUT</sub> is out-of-tolerance by approximately - 5%.
5	Bypass	Reference bypass input. Connecting a 470pF to this input further reduces output noise.
6	V <sub>OUT</sub>	Regulated voltage output.

# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

## TC1072 TC1073

### DETAILED DESCRIPTION

The TC1072 and TC1073 are precision fixed output voltage regulators. (If an adjustable version is desired, please see the TC1070/TC1071/TC1187 data sheet.) Unlike bipolar regulators, the TC1072 and TC1073's supply current does not increase with load current. In addition, V<sub>OUT</sub> remains stable and within regulation at very low load currents (an important consideration in RTC and CMOS RAM battery back-up applications).

Figure 1 shows a typical application circuit. The regulator is enabled any time the shutdown input (SHDN) is at or above V<sub>IH</sub>, and shutdown (disabled) when SHDN is at or below V<sub>IL</sub>. SHDN may be controlled by a CMOS logic gate, or I/O port of a microcontroller. If the SHDN input is not required, it should be connected directly to the input supply. While in shutdown, supply current decreases to 0.05 μA (typical) and V<sub>OUT</sub> falls to zero volts and ERROR is open-circuited.

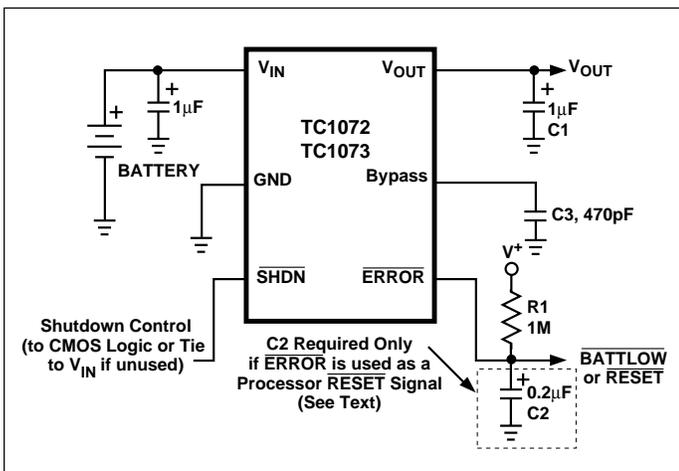


Figure 1. Typical Application Circuit

### ERROR Open Drain Output

ERROR is driven low whenever V<sub>OUT</sub> falls out of regulation by more than -5% (typical). The condition may be caused by low input voltage, output current limiting, or thermal limiting. The ERROR output voltage value (e.g. ERROR = V<sub>OL</sub> at 4.75V (typ) for a 5.0V regulator and 2.85V (typ) for a 3.0V regulator). ERROR output operation is shown in Figure 2.

Note that ERROR is active when V<sub>OUT</sub> falls to V<sub>TH</sub>, and inactive when V<sub>OUT</sub> rises above V<sub>TH</sub> by V<sub>HYS</sub>. As shown in Figure 1, ERROR can be used as a battery low flag, or as a processor RESET signal (with the addition of timing capacitor C2). R1 x C2 should be chosen to maintain ERROR below V<sub>IH</sub> of the processor RESET input for at least 200 msec to allow time for the system to stabilize. Pull-up resistor R1 can be tied to V<sub>OUT</sub>, V<sub>IN</sub> or any other voltage less than (V<sub>IN</sub> + 0.3V).

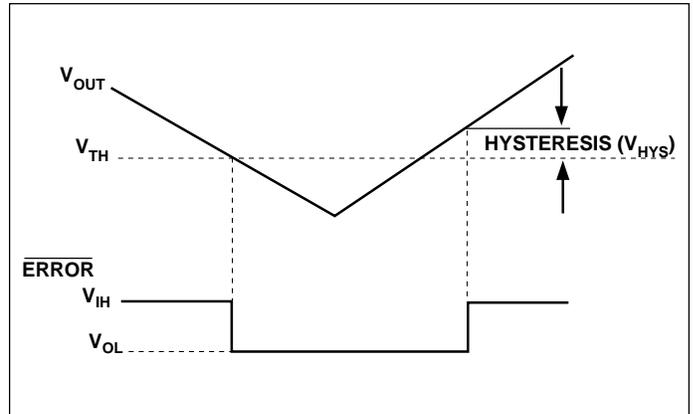


Figure 2. ERROR Output Operation

### Output Capacitor

A 1μF (min) capacitor from V<sub>OUT</sub> to ground is recommended. The output capacitor should have an effective series resistance of 5Ω or less, and a resonant frequency above 1MHz. A 1μF capacitor should be connected from V<sub>IN</sub> to GND if there is more than 10 inches of wire between the regulator and the AC filter capacitor, or if a battery is used as the power source. Aluminum electrolytic or tantalum capacitor types can be used. (Since many aluminum electrolytic capacitors freeze at approximately -30°C, solid tantalums are recommended for applications operating below -25°C.) When operating from sources other than batteries, supply-noise rejection and transient response can be improved by increasing the value of the input and output capacitors and employing passive filtering techniques.

### Bypass Input

A 470pF capacitor connected from the Bypass input to ground reduces noise present on the internal reference, which in turn significantly reduces output noise. If output noise is not a concern, this input may be left unconnected. Larger capacitor values may be used, but results in a longer time period to rated output voltage when power is initially applied.

### Thermal Considerations

#### Thermal Shutdown

Integrated thermal protection circuitry shuts the regulator off when die temperature exceeds 160°C. The regulator remains off until the die temperature drops to approximately 150°C.

#### Power Dissipation

The amount of power the regulator dissipates is primarily a function of input and output voltage, and output current.

# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

TC1072  
TC1073

The following equation is used to calculate worst case *actual* power dissipation:

$$P_D \approx (V_{IN_{MAX}} - V_{OUT_{MIN}})I_{LOAD_{MAX}}$$

Where:

$P_D$  = Worst case actual power dissipation

$V_{IN_{MAX}}$  = Maximum voltage on  $V_{IN}$

$V_{OUT_{MIN}}$  = Minimum regulator output voltage

$I_{LOAD_{MAX}}$  = Maximum output (load) current

Equation 1.

The maximum *allowable* power dissipation (Equation 2) is a function of the maximum ambient temperature ( $T_{AMAX}$ ), the maximum allowable die temperature (125°C) and the thermal resistance from junction-to-air ( $\theta_{JA}$ ). SOT-23A-6 package has a  $\theta_{JA}$  of approximately 220°C/Watt when mounted on a single layer FR4 dielectric copper clad PC board.

$$P_{D_{MAX}} = \frac{(T_{J_{MAX}} - T_{AMAX})}{\theta_{JA}}$$

Where all terms are previously defined.

Equation 2.

Equation 1 can be used in conjunction with Equation 2 to ensure regulator thermal operation is within limits. For example:

Given:

$$V_{IN_{MAX}} = 3.0V \pm 5\%$$

$$V_{OUT_{MIN}} = 2.7V - 2.5\%$$

$$I_{LOAD} = 40mA$$

$$T_{AMAX} = 55^\circ C$$

- Find:
1. Actual power dissipation
  2. Maximum allowable dissipation

Actual power dissipation:

$$\begin{aligned} P_D &\approx (V_{IN_{MAX}} - V_{OUT_{MIN}})I_{LOAD_{MAX}} \\ &= [(3.0 \times 1.05) - (2.7 \times .975)]40 \times 10^{-3} \\ &= 20.7mW \end{aligned}$$

Maximum allowable power dissipation:

$$P_{D_{MAX}} = \frac{(T_{J_{MAX}} - T_{AMAX})}{\theta_{JA}}$$

$$= \frac{(125 - 55)}{220}$$

$$= 318mW$$

In this example, the TC1072 dissipates a maximum of only 20.7mW; far below the allowable limit of 318mW. In a similar manner, Equation 1 and Equation 2 can be used to calculate maximum current and/or input voltage limits.

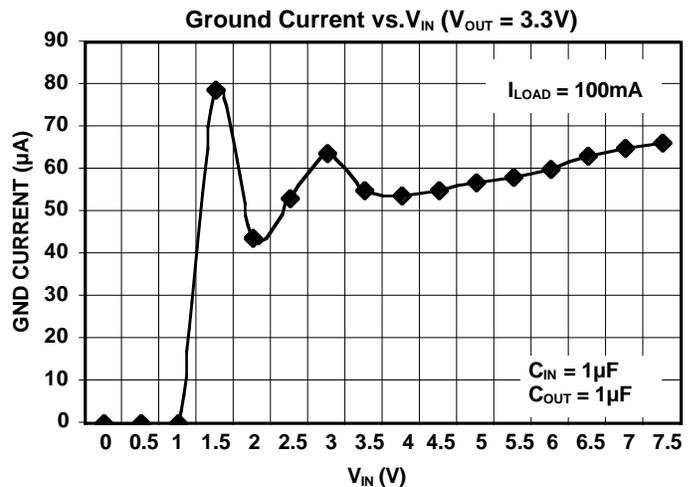
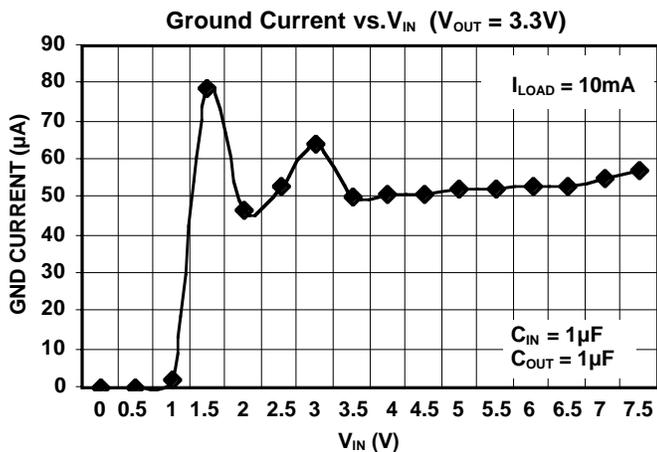
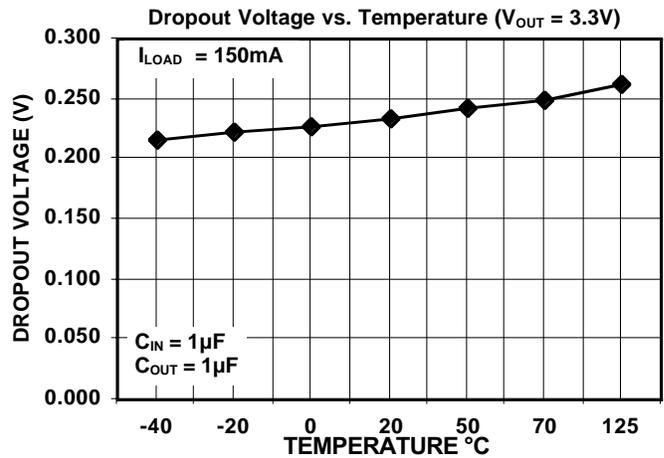
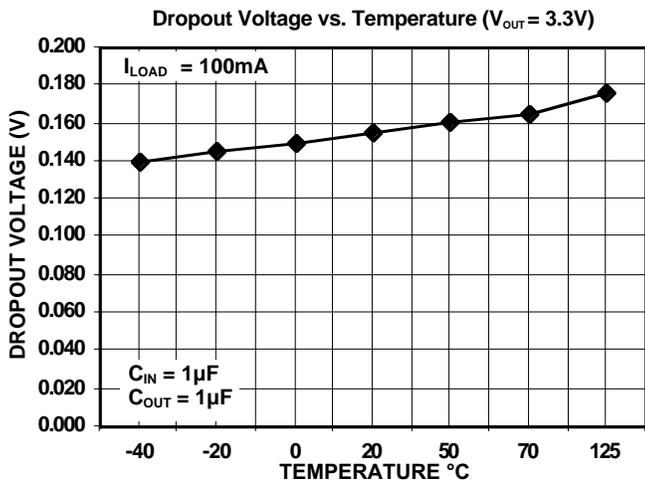
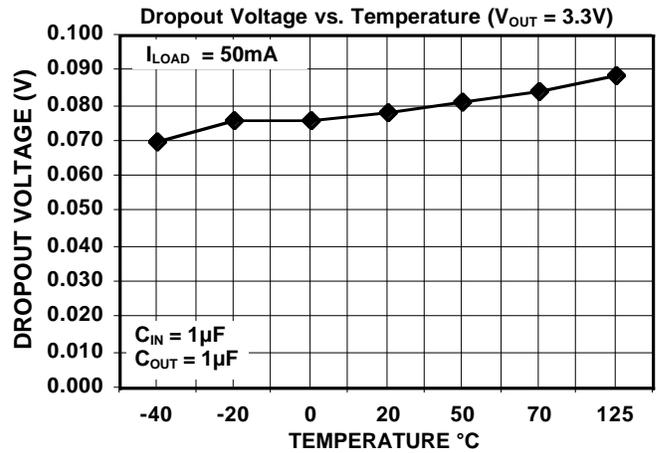
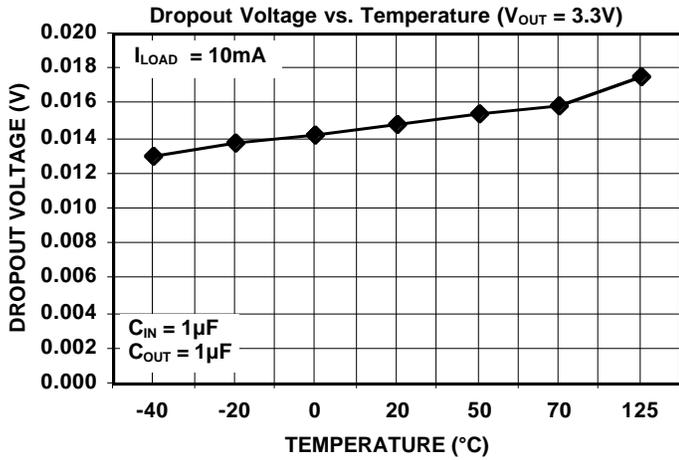
## Layout Considerations

The primary path of heat conduction out of the package is via the package leads. Therefore, layouts having a ground plane, wide traces at the pads, and wide power supply bus lines combine to lower  $\theta_{JA}$  and therefore increase the maximum allowable power dissipation limit.

# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

TC1072  
TC1073

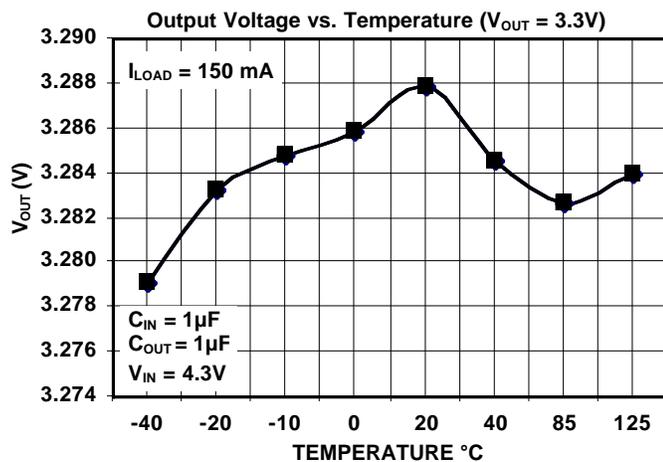
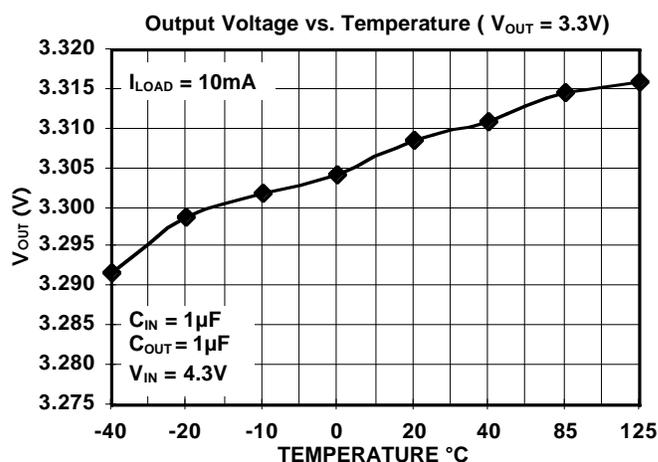
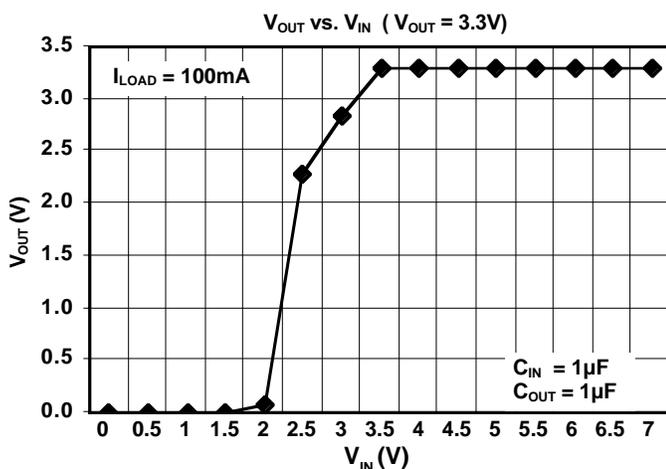
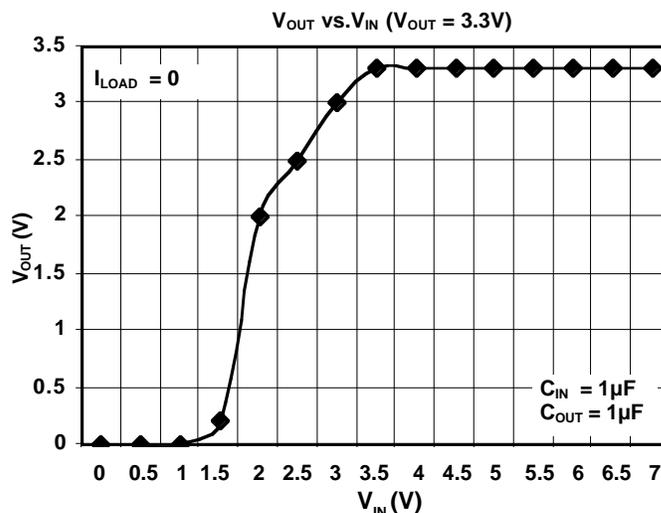
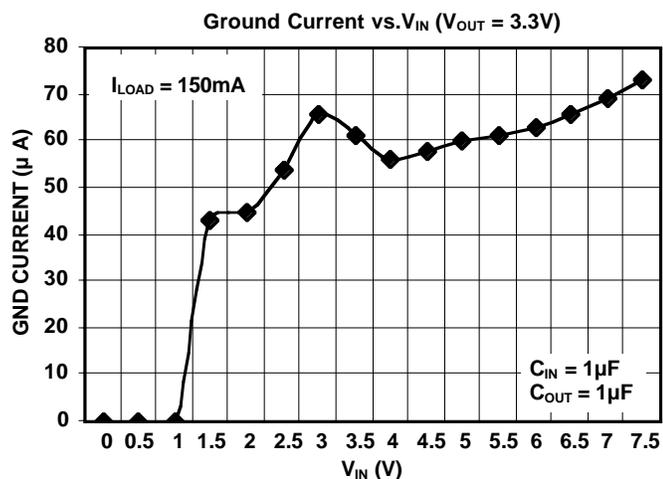
TYPICAL CHARACTERISTICS: (Unless otherwise specified, all parts are measured at Temperature = 25°C)



# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and $V_{REF}$ Bypass

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TC1073

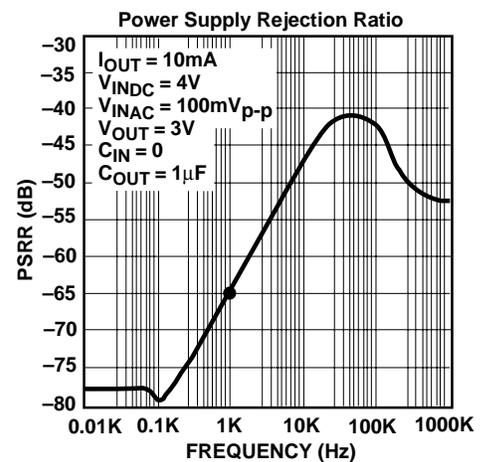
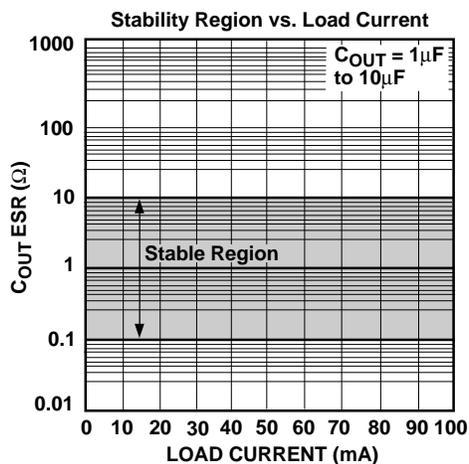
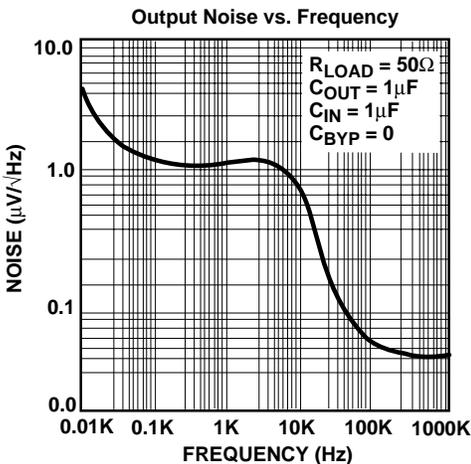
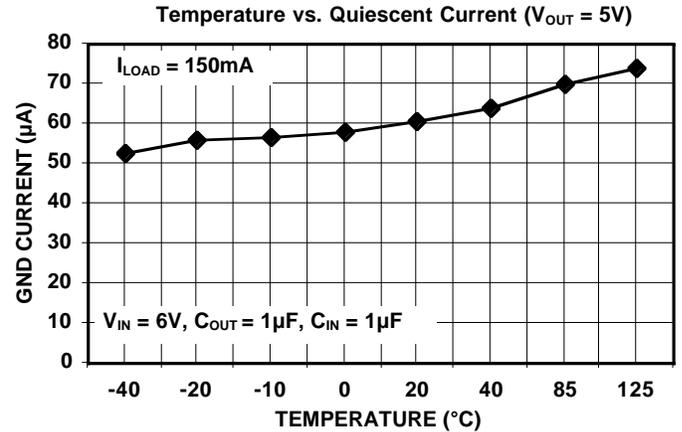
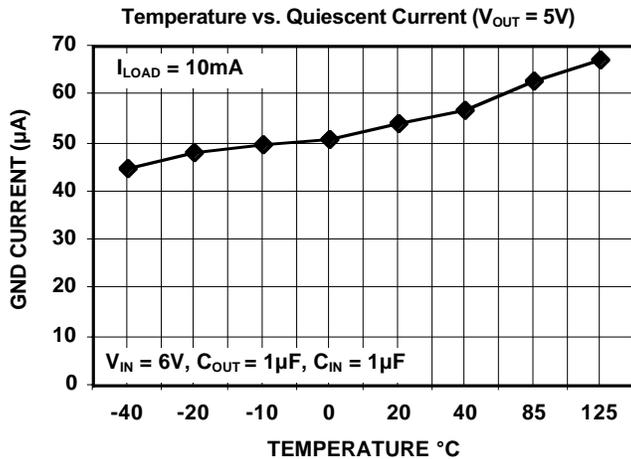
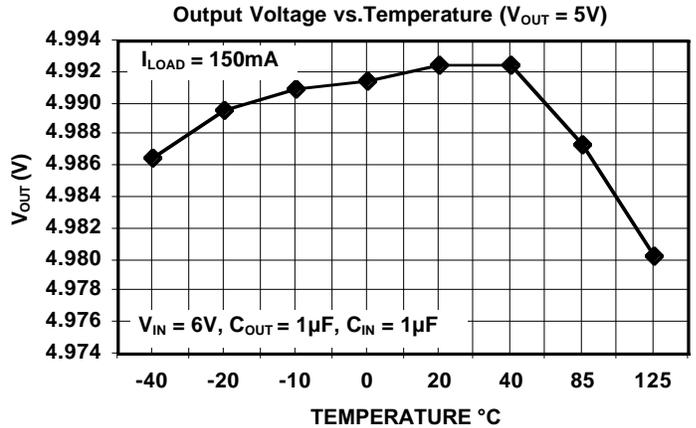
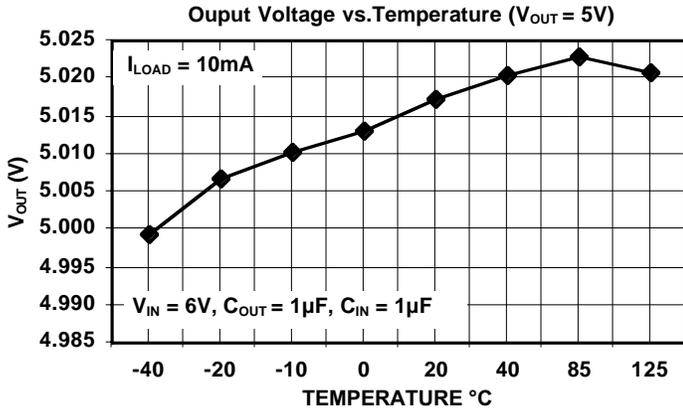
**TYPICAL CHARACTERISTICS:** (Unless otherwise specified, all parts are measured at Temperature = 25°C)



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TC1072  
TC1073

## TYPICAL CHARACTERISTICS



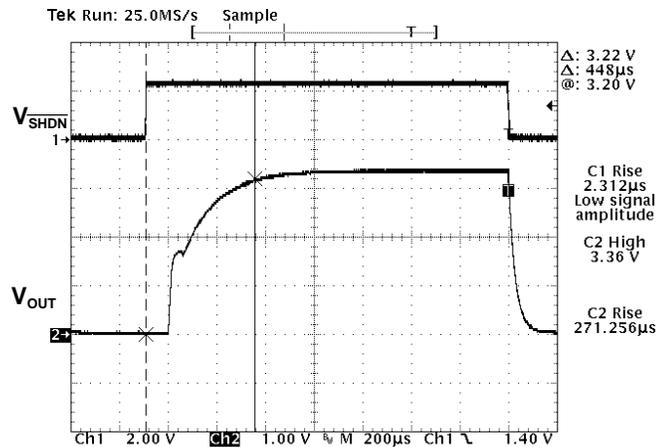
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TC1073

## TYPICAL CHARACTERISTICS

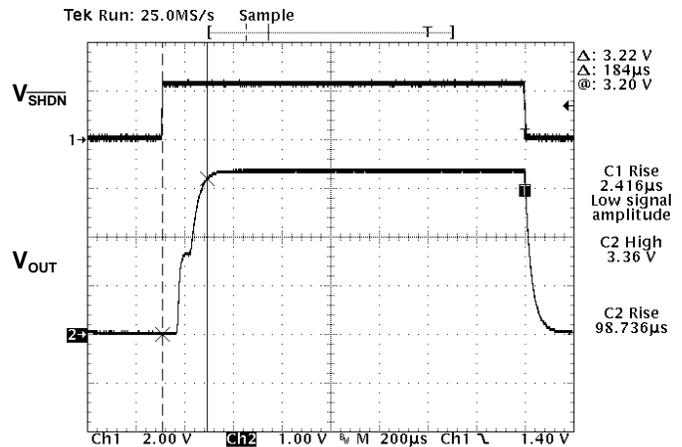
Measure Rise Time of 3.3V LDO with Bypass Capacitor

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 470pF$ ,  $I_{LOAD} = 100mA$   
 $V_{IN} = 4.3V$ , Temp = 25°C, Rise Time = 448 $\mu S$



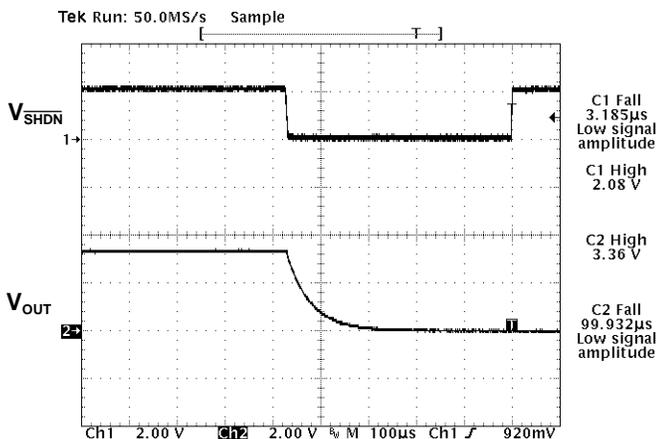
Measure Rise Time of 3.3V LDO without Bypass Capacitor

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 0pF$ ,  $I_{LOAD} = 100mA$   
 $V_{IN} = 4.3V$ , Temp = 25°C, Rise Time = 184 $\mu S$



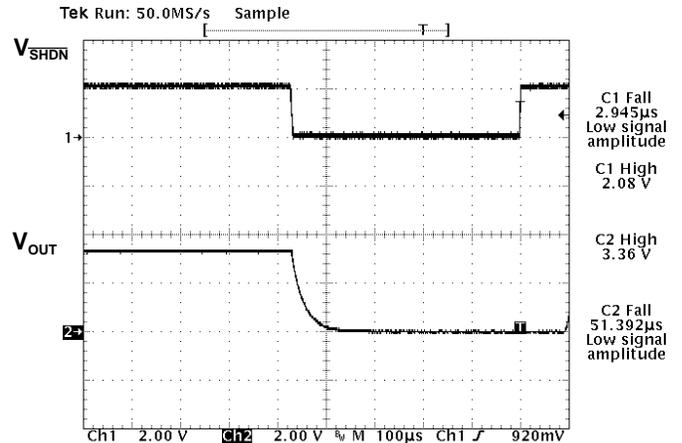
Measure Fall Time of 3.3V LDO with Bypass Capacitor

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 470pF$ ,  $I_{LOAD} = 50mA$   
 $V_{IN} = 4.3V$ , Temp = 25°C, Fall Time = 100 $\mu S$



Measure Fall Time of 3.3V LDO without Bypass Capacitor

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 0pF$ ,  $I_{LOAD} = 100mA$   
 $V_{IN} = 4.3V$ , Temp = 25°C, Fall Time = 52 $\mu S$



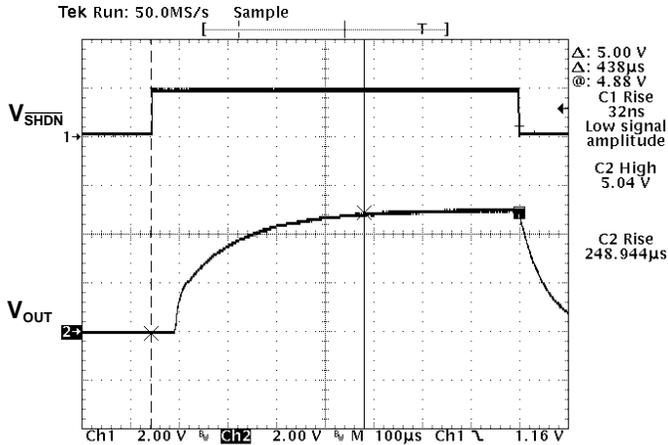
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TC1072  
TC1073

## TYPICAL CHARACTERISTICS

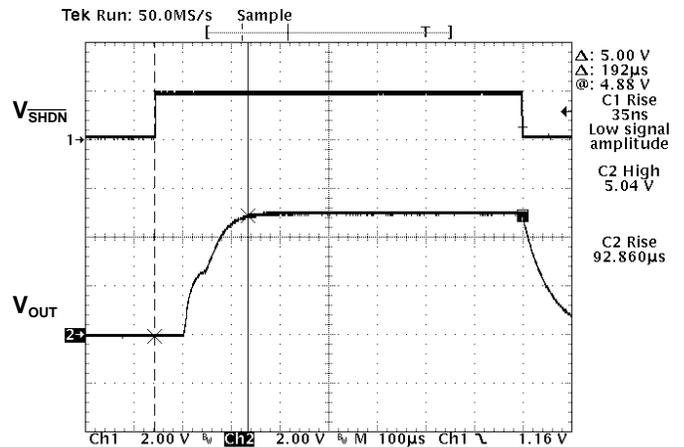
Measure Rise Time of 5.0V LDO with Bypass Capacitor

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 470pF$ ,  $I_{LOAD} = 100mA$   
 $V_{IN} = 6V$ , Temp = 25°C, Rise Time = 390μs



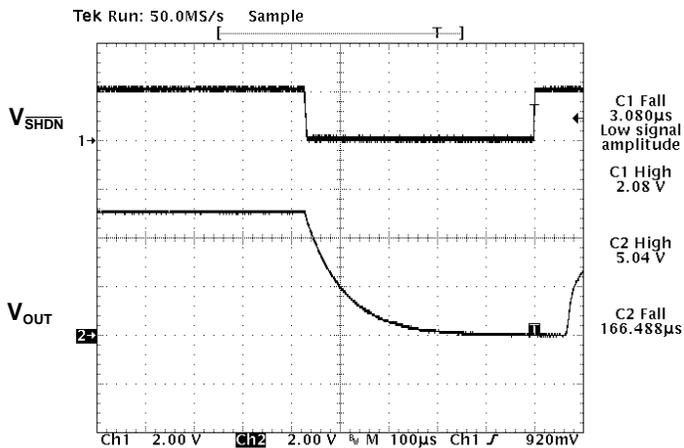
Measure Rise Time of 5.0V LDO without Bypass Capacitor

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 0$ ,  $I_{LOAD} = 100mA$   
 $V_{IN} = 6V$ , Temp = 25°C, Rise Time = 192μs



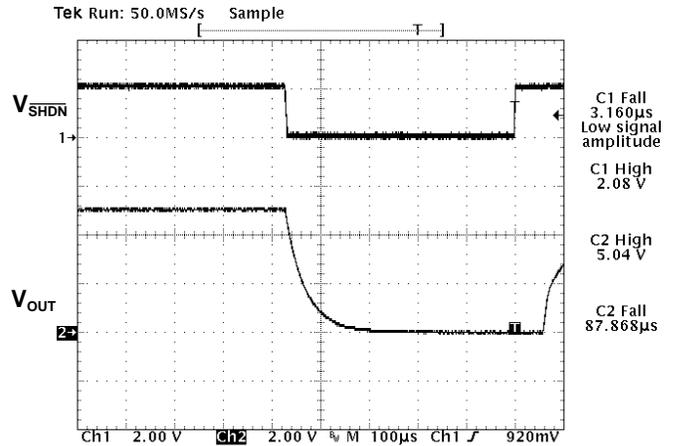
Measure Fall Time of 5.0V LDO with Bypass Capacitor

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 470pF$ ,  $I_{LOAD} = 50mA$   
 $V_{IN} = 6V$ , Temp = 25°C, Fall Time = 167μs



Measure Fall Time of 5.0V LDO without Bypass Capacitor

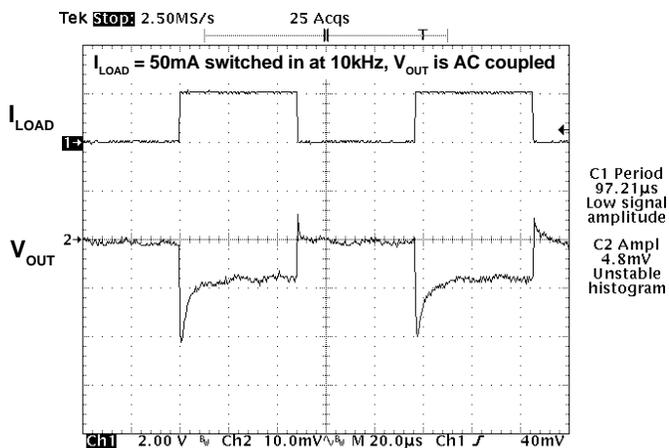
Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 1\mu F$ ,  $C_{BYP} = 0pF$ ,  $I_{LOAD} = 100mA$   
 $V_{IN} = 6V$ , Temp = 25°C, Fall Time = 88μs



## TYPICAL CHARACTERISTICS

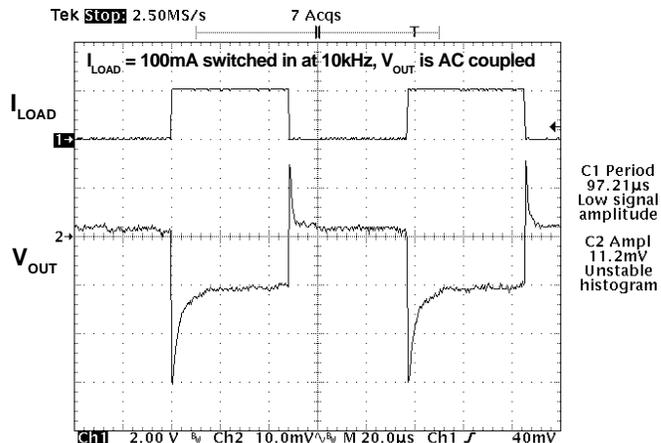
Load Regulation of 3.3V LDO

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 2.2\mu F$ ,  $C_{BYP} = 470pF$ ,  
 $V_{IN} = V_{OUT} + 0.25V$ , Temp = 25°C



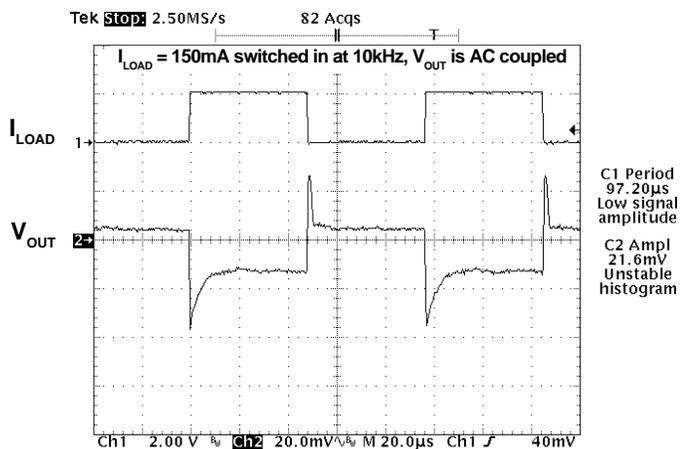
Load Regulation of 3.3V LDO

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 2.2\mu F$ ,  $C_{BYP} = 470pF$ ,  
 $V_{IN} = V_{OUT} + 0.25V$ , Temp = 25°C



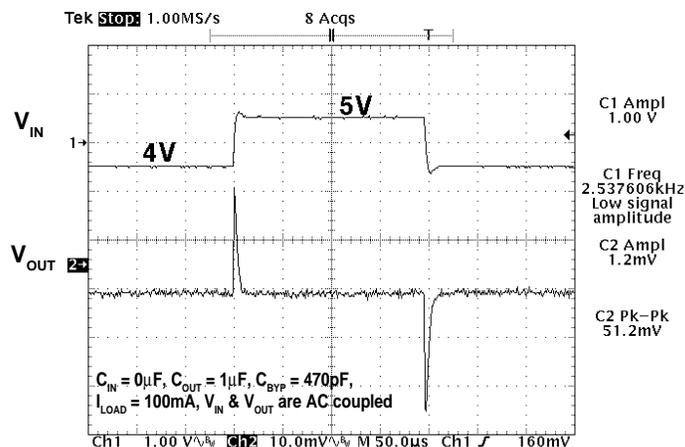
Load Regulation of 3.3V LDO

Conditions:  $C_{IN} = 1\mu F$ ,  $C_{OUT} = 2.2\mu F$ ,  $C_{BYP} = 470pF$ ,  
 $V_{IN} = V_{OUT} + 0.25V$ , Temp = 25°C



Line Regulation of 3.3V LDO

Conditions:  $V_{IN} = 4V$ , + 1V Squarewave @ 2.5kHz,



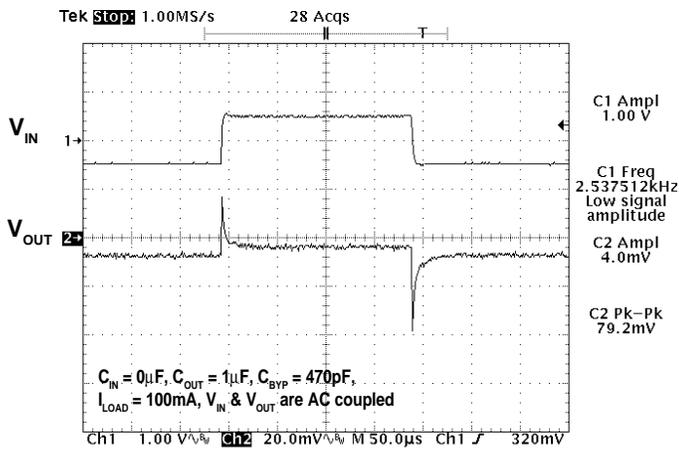
# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

TC1072  
TC1073

## TYPICAL CHARACTERISTICS

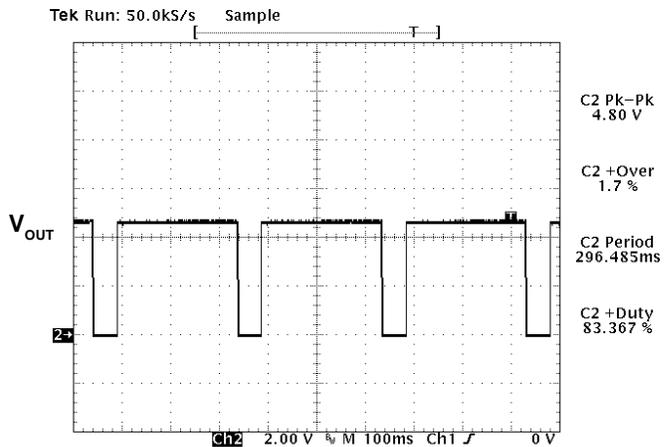
Line Regulation of 5.0V LDO

Conditions:  $V_{IN} = 6V, +1V$  Squarewave @ 2.5kHz,



Thermal Shutdown Response of 5.0V LDO

Conditions:  $V_{IN} = 6V, C_{IN} = 0\mu F, C_{OUT} = 1\mu F$

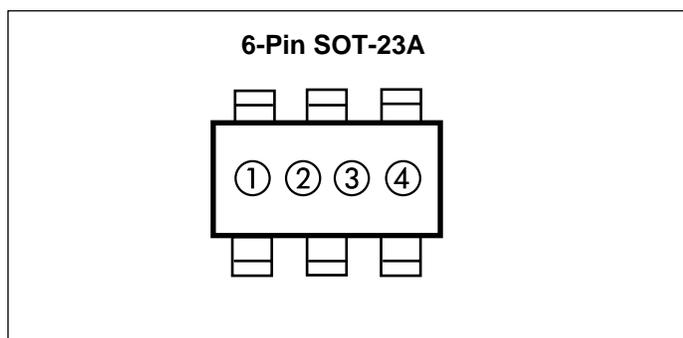
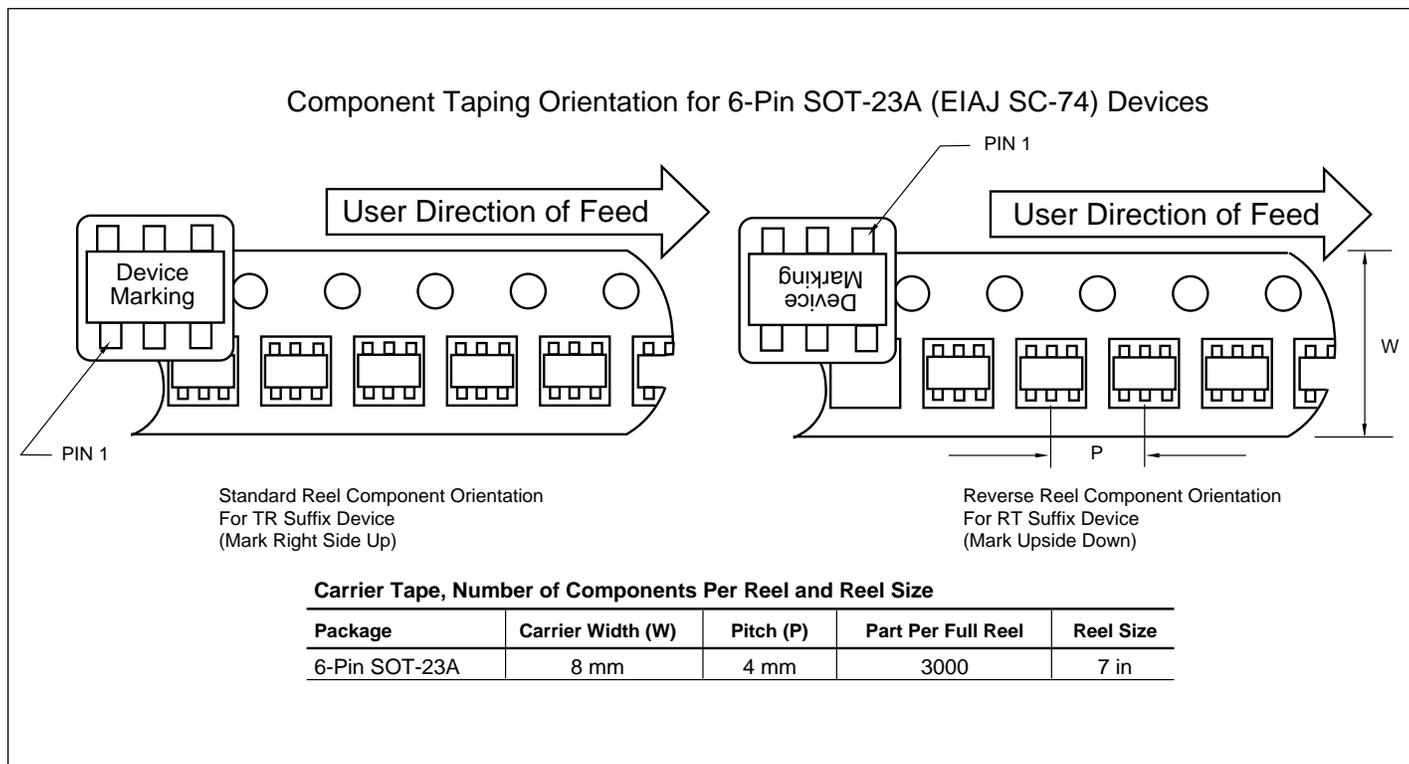


$I_{LOAD}$  was increased until temperature of die reached about 160°C, at which time integrated thermal protection circuitry shuts the regulator off when die temperature exceeds approximately 160°C. The regulator remains off until die temperature drops to approximately 150°C.

# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

**TC1072**  
**TC1073**

## TAPING FORM



① & ② = part number code + temperature range and voltage

(V)	TC1072 Code	TC1073 Code
2.5	E1	F1
2.7	E2	F2
2.8	EZ	FZ
2.85	E8	F8
3.0	E3	F3
3.3	E5	F5
3.6	E9	F9
4.0	E0	F0
5.0	E7	F7

③ represents year and quarter code

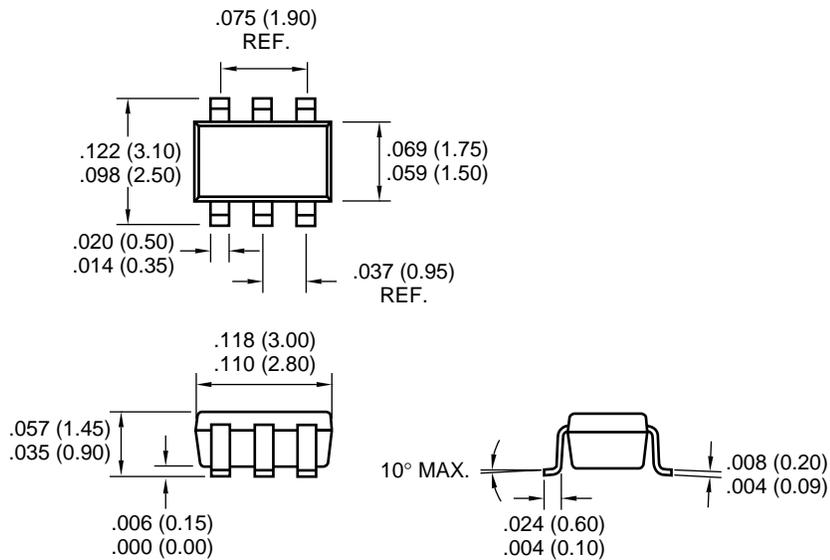
④ represents lot ID number

# 50mA and 100mA CMOS LDOs with Shutdown, Error Output and V<sub>REF</sub> Bypass

TC1072  
TC1073

## PACKAGE DIMENSIONS

### 6-Pin SOT-23A (EIAJ SC-74)



**NOTE:** \*6-Pin SOT-23A is equivalent to the EIAJ (SC-74A)

Dimensions: inches (mm)



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2355 West Chandler Blvd.  
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#### San Jose

Microchip Technology Inc.  
2107 North First Street, Suite 590  
San Jose, CA 95131  
Tel: 408-436-7950 Fax: 408-436-7955

#### Toronto

6285 Northam Drive, Suite 108  
Mississauga, Ontario L4V 1X5, Canada  
Tel: 905-673-0699 Fax: 905-673-6509

### ASIA/PACIFIC

#### China - Beijing

Microchip Technology Beijing Office  
Unit 915  
New China Hong Kong Manhattan Bldg.  
No. 6 Chaoyangmen Beidajie  
Beijing, 100027, No. China  
Tel: 86-10-85282100 Fax: 86-10-85282104

#### China - Shanghai

Microchip Technology Shanghai Office  
Room 701, Bldg. B  
Far East International Plaza  
No. 317 Xian Xia Road  
Shanghai, 200051  
Tel: 86-21-6275-5700 Fax: 86-21-6275-5060

#### Hong Kong

Microchip Asia Pacific  
RM 2101, Tower 2, Metroplaza  
223 Hing Fong Road  
Kwai Fong, N.T., Hong Kong  
Tel: 852-2401-1200 Fax: 852-2401-3431

#### India

Microchip Technology Inc.  
India Liaison Office  
Divyasree Chambers  
1 Floor, Wing A (A3/A4)  
No. 11, OisShaughnessey Road  
Bangalore, 560 025, India  
Tel: 91-80-2290061 Fax: 91-80-2290062

#### Japan

Microchip Technology Intl. Inc.  
Benex S-1 6F  
3-18-20, Shinyokohama  
Kohoku-Ku, Yokohama-shi  
Kanagawa, 222-0033, Japan  
Tel: 81-45-471-6166 Fax: 81-45-471-6122

#### Korea

Microchip Technology Korea  
168-1, Youngbo Bldg. 3 Floor  
Samsung-Dong, Kangnam-Ku  
Seoul, Korea  
Tel: 82-2-554-7200 Fax: 82-2-558-5934

### ASIA/PACIFIC (continued)

#### Singapore

Microchip Technology Singapore Pte Ltd.  
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#07-02 Prime Centre  
Singapore, 188980  
Tel: 65-334-8870 Fax: 65-334-8850

#### Taiwan

Microchip Technology Taiwan  
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Tung Hua North Road  
Taipei, 105, Taiwan  
Tel: 886-2-2717-7175 Fax: 886-2-2545-0139

### EUROPE

#### Australia

Microchip Technology Australia Pty Ltd  
Suite 22, 41 Rawson Street  
Epping 2121, NSW  
Australia  
Tel: 61-2-9868-6733 Fax: 61-2-9868-6755

#### Denmark

Microchip Technology Denmark ApS  
Regus Business Centre  
Lautrup høj 1-3  
Ballerup DK-2750 Denmark  
Tel: 45 4420 9895 Fax: 45 4420 9910

#### France

Arizona Microchip Technology SARL  
Parc d'Activite du Moulin de Massy  
43 Rue du Saule Trapu  
Batiment A - 1er Etage  
91300 Massy, France  
Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

#### Germany

Arizona Microchip Technology GmbH  
Gustav-Heinemann Ring 125  
D-81739 Munich, Germany  
Tel: 49-89-627-144 0 Fax: 49-89-627-144-44

#### Germany

Analog Product Sales  
Lochamer Strasse 13  
D-82152 Martinsried, Germany  
Tel: 49-89-895650-0 Fax: 49-89-895650-22

#### Italy

Arizona Microchip Technology SRL  
Centro Direzionale Colleoni  
Palazzo Taurus 1 V. Le Colleoni 1  
20041 Agrate Brianza  
Milan, Italy  
Tel: 39-039-65791-1 Fax: 39-039-6899883

#### United Kingdom

Arizona Microchip Technology Ltd.  
505 Eskdale Road  
Winnersh Triangle  
Wokingham  
Berkshire, England RG41 5TU  
Tel: 44 118 921 5869 Fax: 44-118 921-5820

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